

SW Test Workshop

Development of Latest Generation Hole Geometries for Probe Card Applications

Dr Mike Osborne, OpTek Systems Ltd. Andrew Webb, OpTek Systems Inc. Henry Lu, OpTek Asia Pacific

Introduction and Motivation

OpTek Systems is a provider of precision laser drilling either through subcontract manufacturing services or turnkey machines tools. OpTek has been supplying precision drilled holes to the wafer test industry for more than 10 years and supports the market from its locations in Asia, Europe and USA. For vertical probe cards, there is an ongoing challenge to position more holes closer together on a tighter pitch with narrower walls; and including non-round hole geometries such as square and rectangular holes, whilst simultaneously reducing the price per hole.

This poster introduces OpTek's recent Research and Development combined with process optimization to achieve acceptable hole quality with acceptable structural integrity whilst considering drill speeds.

Special attention is given to techniques for high speed and high quantity machining of square holes whilst minimizing both corner radius and taper. Laser performance and the relevance of latest generation ultra short duration pulsed parameters are considered for this application.

Analysis of results achieved in various configurations are reviewed combined with recommendations.

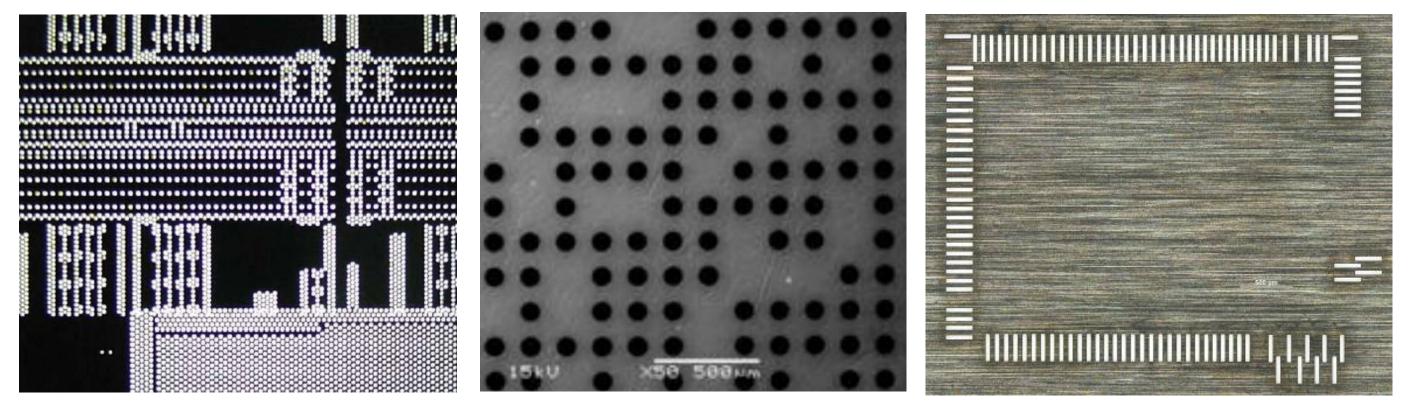


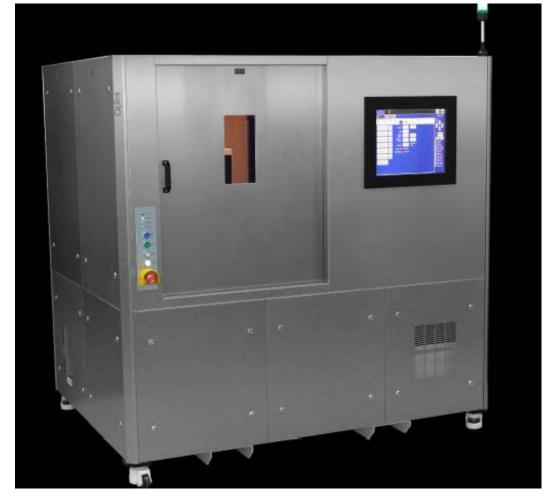
Figure 1 – Typical Vertical Probe Card Arrays

Equipment and Methods

The manufacturing of sample holes analyzed for this report were created on lab based equipment located in-house at OpTek Systems. There are many equipment variables and Table 1 outlines the options considered for this processing.

Laser Type	Beam Delivery	Positioning (X-Y Motion)
<30ns pulsed	Direct write	CNC air bearing stages
<10ps pulsed	Galvo scan	Galvo scan
<900fs pulsed	OpTek trepan head	

All processing was performed with short duration pulsed lasers with the intent to avoid thermal damage to the substrates.



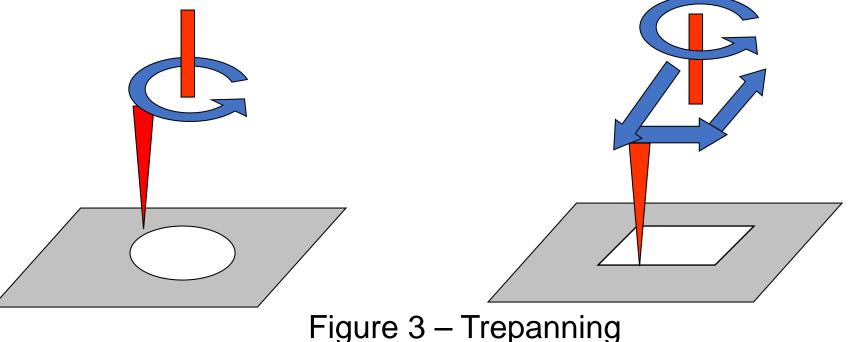
The workstation employed has a flexible configuration in that it can accept multiple laser types and provides a large open space for the beam delivery and motion systems. This type of tool is being used for Research and

Development through to Production laser micro drilling and milling.

Figure 2 shows the machine finished in stainless steel for cleanroom compatibility

Figure 2 – OpTek MM6500 Workstation

To satisfy the demanding hole quality and positional accuracies a combination of trepanning and stages were employed. As illustrated in figure 3 trepanning is a technique for offsetting the beam in a circular motion to precisely mill to the required diameter. Further control and sequencing of this movement enables high speed trepanning of non round holes.



The CNC stages were then used to position the material under the laser beam locating the holes in the X-Y array locations.

SW Test Workshop 2017, June 4 to 7, 2017

Materials Tested

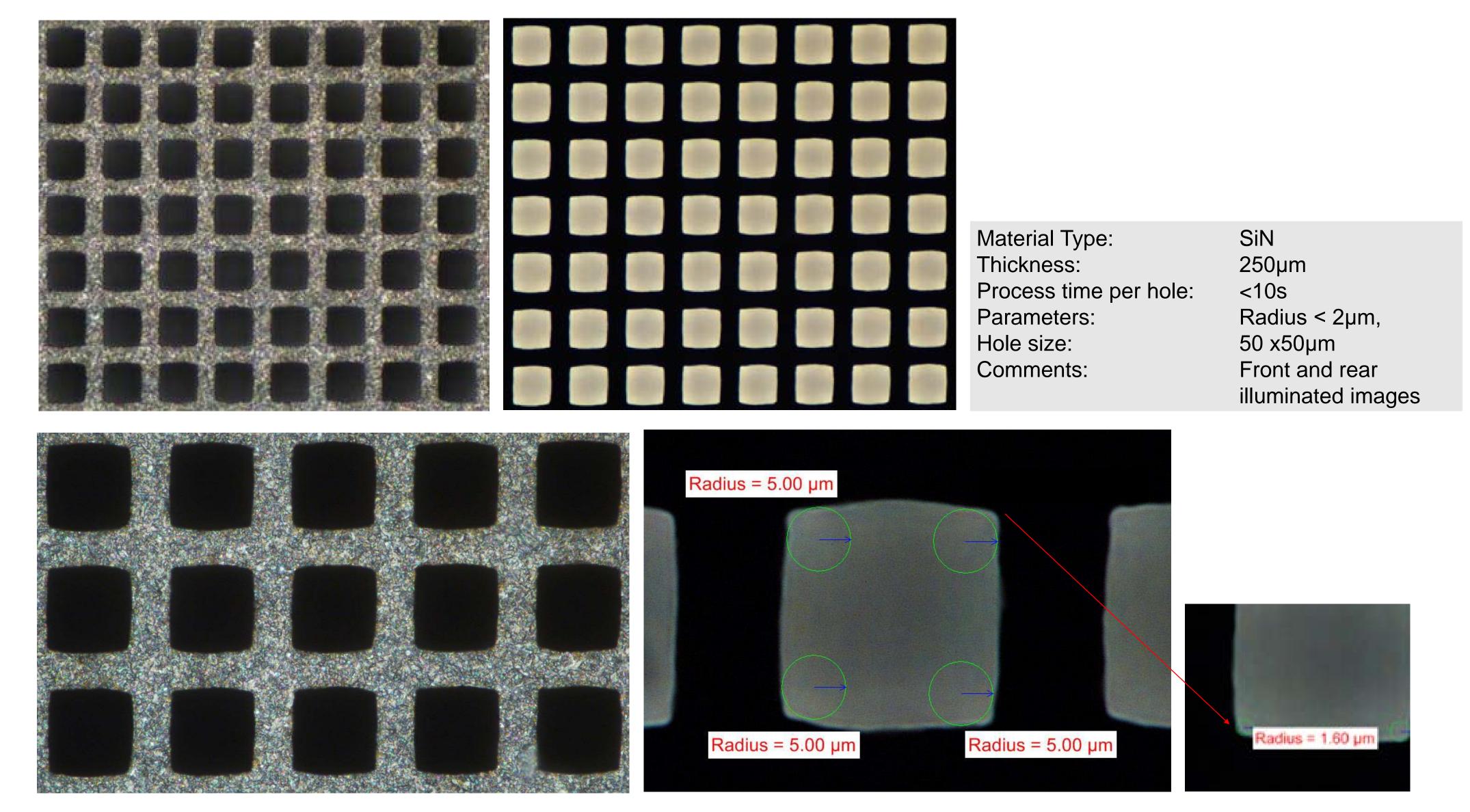
The materials considered for assessment were identified through OpTek's interaction with users and customers in this field. They include:

Test Procedures

Arrays of holes simulating typical requirements were processed with the resulting drilled holes being assessed through microscope imaging measuring the dimensions, location and visually assessing hole quality.

Results: The Question of Corners - Radius Minimization

For square and rectangular holes, the key to performance is the corner radius. Minimizing this radius allows the maximum diameter of pin to be inserted in the smallest possible hole. It also allows for adjacent holes to be placed ever closer together without breakdown of the adjoining wall. The images below show 50µm square holes machined through 250µm SiN.



Ceramic	Polymer	Thickness
SiN	Cirlex	125
PVII	Mylar	250
Macor	PEEK	350
Alumina		450
		600
		750

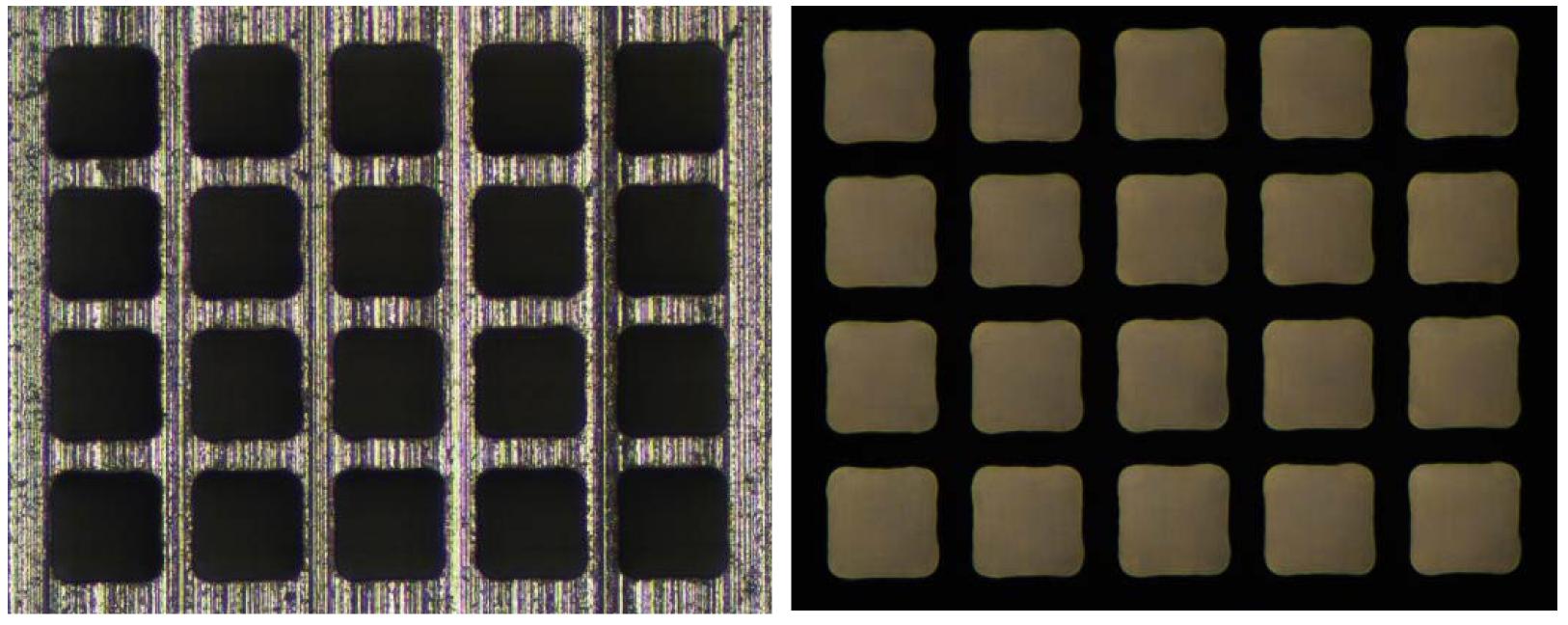
The Question of Corners - Dog Bone Filets

An alternative means of providing clearance in the corners is to add an external radius, the so-called "dog-bone filet". The rather extreme example below illustrates to process:

	Material Type: Thickness: Time/hole: Parameters: Comments:SiN 250µm 30x30µm; 8µm radius filet Consideration has to be given to proximity of adjacent holes and the reduction in wall thickness due to corners
--	---

comers

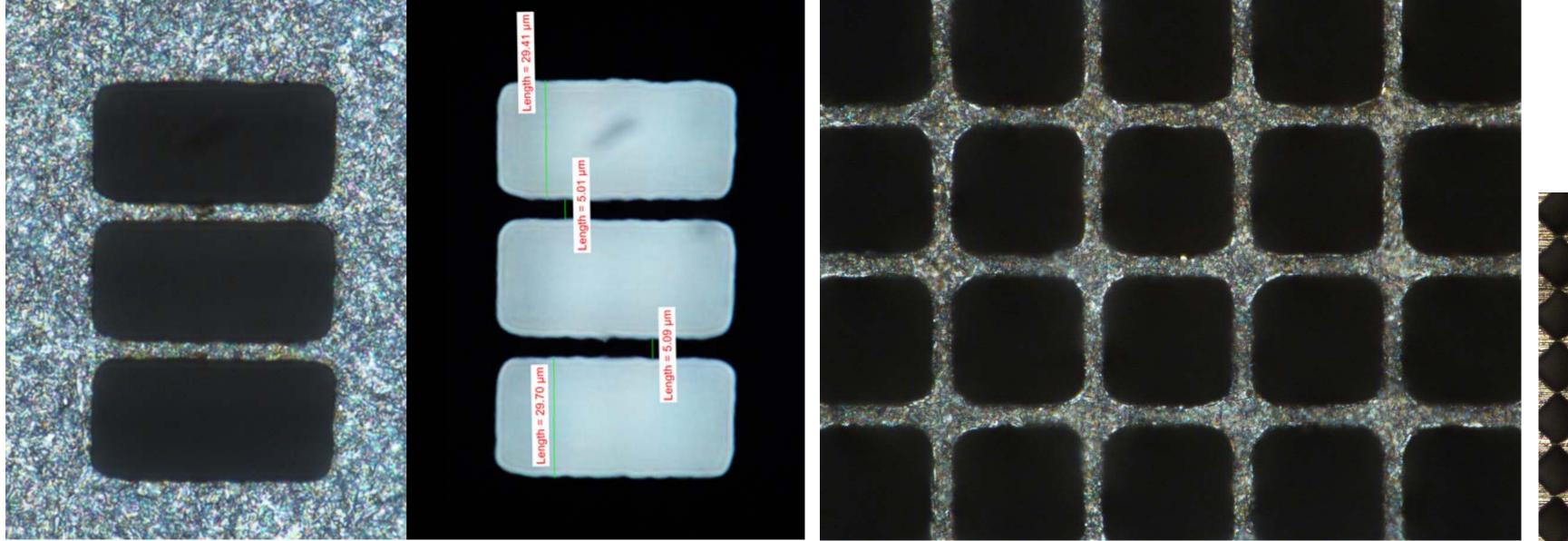
A more typical application of this is shown below:

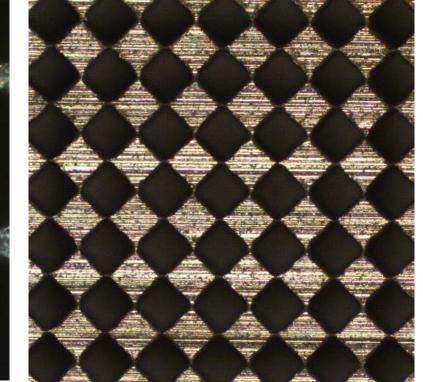


SW Test Workshop 2017, June 4 to 7, 2017

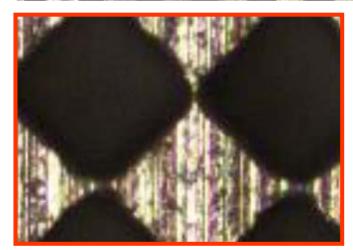
The Question of Walls

Achieving the tightest pitch can result in damage to the walls between holes and the top flat surface sometimes used for assisting the positioning of pins. Images below illustrate minimum dimensions possible:

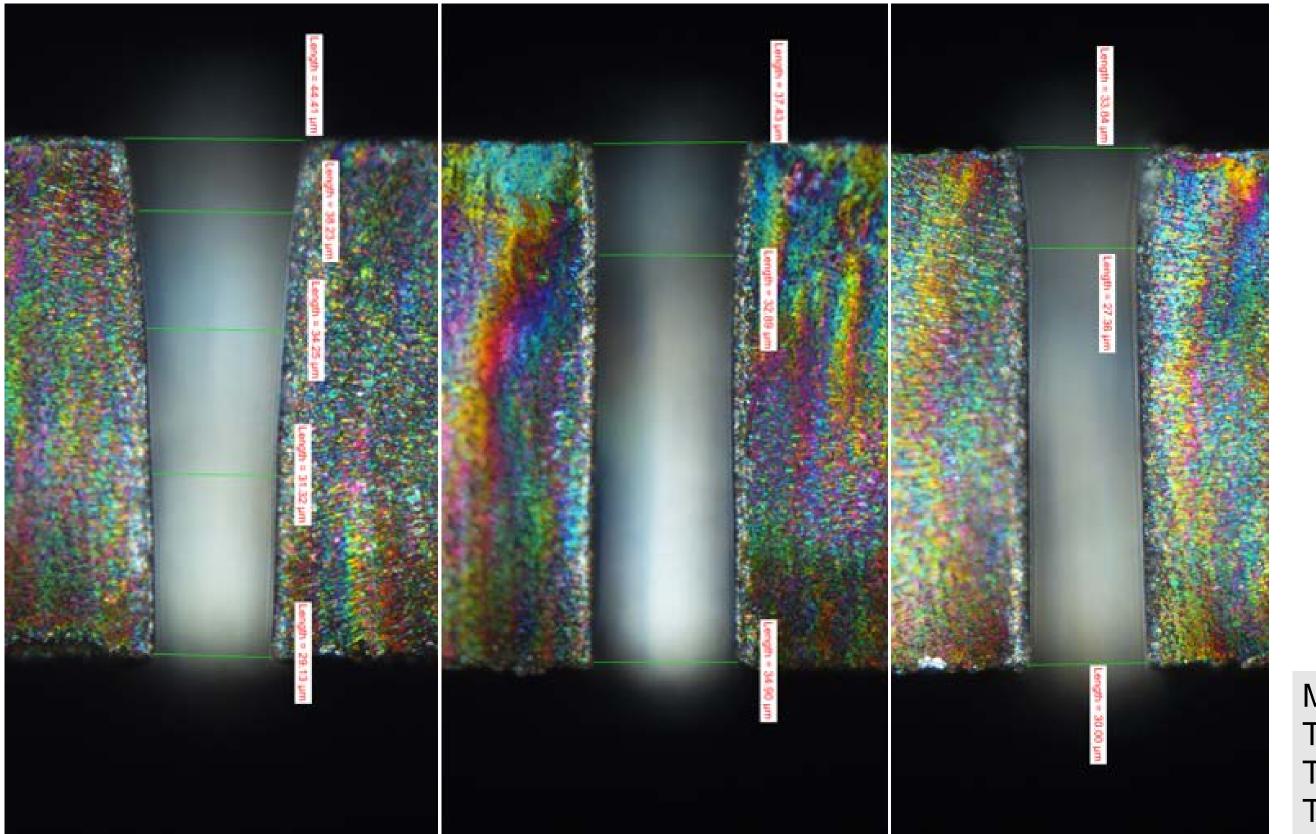




- Material Type:SiNThickness:250Time/hole:<5s</td>Parameters:RecDiamond40x4Square45x4
 - 250µm <5s Rectangular 60x30µm; Walls 5µm 40x40µm; Walls <2µm between corners 45x45µm; Walls <6µm



Positive (left), zero (center) and negative (right) taper possible. This is important for both assembly of pins into the probe card and reducing wall damage between adjacent holes.



Material Type:	SiN
Thickness:	125µm
Time/hole:	<2s
Taper:	Left +6.8°, center 0°, right -1.8°

Conclusions

The requirements are increasingly more challenging and when considering the smaller sizes and tighter tolerances, non round holes cannot be drilled using traditional techniques - laser is a proving to be a good fit.

As presented, the advantages of laser drilling include:

- Flexible processing routines
- Avoids mechanical drill failure
- Feature sizes compatible with current designs

High speed drilling of Non Round Holes now possible.

Potential issues observed with Laser drilling:

- Accuracy and tolerances require expensive hardware
- Material thickness >1mm result in excessive drill times
- Taper and entrance rounding, but manageable attributes of laser drilling

Similar results can be achieved in round holes with even shorter drill times and greater taper control. Future processing to be performed with ultrafast laser types to explore what additional improvements can be realized.

Questions ?

If you have any questions, please contact:

Mike Osborne: **Europe & ROW**: 12-14 Blacklands Way, Abingdon Business Park, Oxford, OX14 1DY, UK. Tel +44 1235 539182 Andy Webb: **USA & Americas**: 12 Pilgrim Road, Greenville, SC 29607, USA, Tel: +1 978 652 8331 Henry Lu: **Asia:** 1008, Bldg A, Dingfeng Intl. Plaza, Dongguan, Guangdong 523000, China, Tel +86 13901187950

Website: www.opteksystems.com Email: info@opteksystems.com

References

SWT Workshop Proceedings